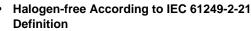


# NTJS3157NT1G-VB Datasheet N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A) <sup>a, e</sup>	Q <sub>g</sub> (Typ.)			
30	0.023 at V <sub>GS</sub> = 10 V	4.5	4.2 nC			
30	0.027 at V <sub>GS</sub> = 4.5 V	4.0	4.2 110			

# **FEATURES**





- Trench Power MOSFET
- Low On-Resistance
- 100 % R<sub>q</sub> Tested
- Compliant to RoHS Directive 2002/95/EC

### **APPLICATIONS**

• DC/DC Converters, High Speed Switching

	S	<b>SOT-363</b> C-70 (6-LEAD	S)	
D	1	1 1	6	D
D	2		5	D
G	3		4	S
		Top View	_	

ABSOLUTE MAXIMUM RATIN	I <b>GS</b> (T <sub>A</sub> = 25 °C	, unless other	rwise noted)	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	30	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v
	T <sub>C</sub> = 25 °C		4.5 <sup>e</sup>	
Continuous Proin Current (T = 150 °C)	T <sub>C</sub> = 70 °C	1 , [	4.0 <sup>e</sup>	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C		4.1 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C	1	3.6 <sup>b, c</sup>	А
Pulsed Drain Current (t = 300 μs)		I <sub>DM</sub>	25	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C		2.1	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	l <sub>S</sub>	1.1 <sup>b, c</sup>	
	T <sub>C</sub> = 25 °C		2.5	
Maximum Power Discipation	T <sub>C</sub> = 70 °C	1 , [	1.6	W
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	1.3 <sup>b, c</sup>	VV
	T <sub>A</sub> = 70 °C	1	0.8 <sup>b, c</sup>	
Operating Junction and Storage Temperature	e Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C
Soldering Recommendations (Peak Tempera	ature)		260	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 5 s	R <sub>thJA</sub>	75	100	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	40	50	C/ V V	

- a. Based on  $T_C = 25$  °C.
- b. Surface mounted on 1" x 1" FR4 board.
- d. Maximum under steady state conditions is 166 °C/W.
- e. Package limited.

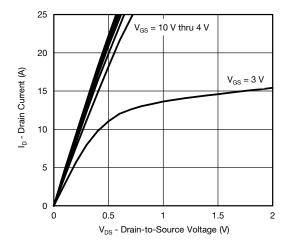


Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$	30			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		30		m\//°(
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 4.8		mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	0.5		2.5	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zana Cata Valtana Busin Comment	1.	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1	μА
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 70 ^{\circ}\text{C}$			10	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le 5 \text{ V}, V_{GS} = 10 \text{ V}$	20			Α
Dania Carras Car Otata Daniata and	В	$V_{GS} = 10 \text{ V}, I_D = 3.5 \text{ A}$		0.023		Ω
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 3 \text{ A}$		0.027		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 15 \text{ V}, I_D = 3.5 \text{ A}$		24		S
Dynamic <sup>b</sup>				1		
Input Capacitance	C <sub>iss</sub>			424		
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		100		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			42		
Total Oats Observe	Qg	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 3.5 \text{ A}$		8.2	13	nC
Total Gate Charge				4.2	7	
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 3.5 \text{ A}$		1.4		
Gate-Drain Charge	$Q_{gd}$			1.4		
Gate Resistance	R <sub>g</sub>	f = 1 MHz	2.5	12.6	25.2	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			6	12	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 3.4 $\Omega$		20	30	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 4.4 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		14	21	1
Fall Time	t <sub>f</sub>			10	20	
Turn-On Delay Time	t <sub>d(on)</sub>			3	6	ns
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 3.4 $\Omega$		11	20	1
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 4.4 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		20	30	1
Fall Time	t <sub>f</sub>			7	14	1
<b>Drain-Source Body Diode Characteristi</b>	cs					
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			2.1	_
Pulse Diode Forward Current	I <sub>SM</sub>				25	A
Body Diode Voltage	V <sub>SD</sub>	$I_S = 4.4 \text{ A}, V_{GS} = 0 \text{ V}$		0.82	1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			13	20	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L = 4.4.4. dl/dt = 100.4/up. T = 25.00		6	12	nC
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 4.4 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		8		
Reverse Recovery Rise Time	t <sub>b</sub>	t <sub>b</sub>		5		ns

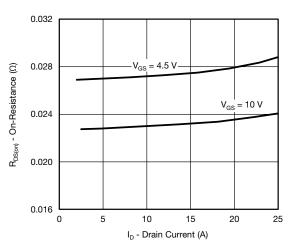
- a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

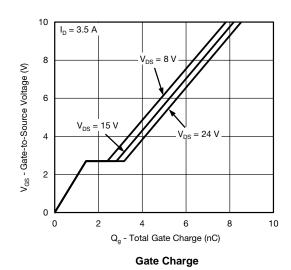




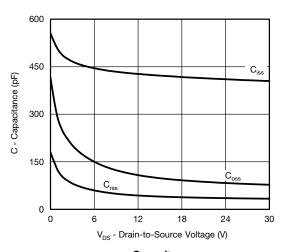
#### **Output Characteristics**



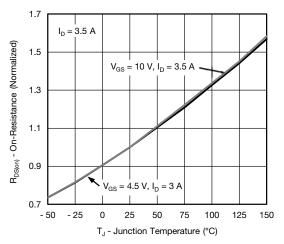
On-Resistance vs. Drain Current and Gate Voltage



**Transfer Characteristics** 

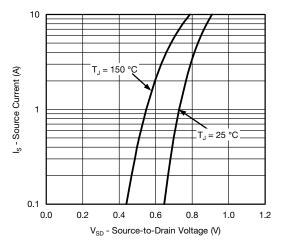


Capacitance

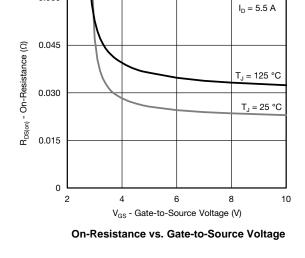


On-Resistance vs. Junction Temperature

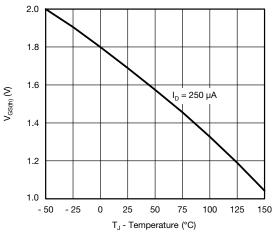




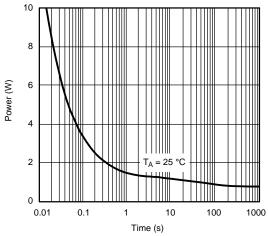
#### Source-Drain Diode Forward Voltage



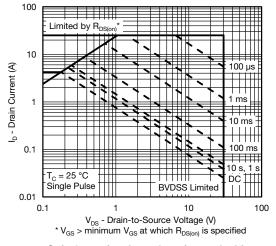
0.060



**Threshold Voltage** 

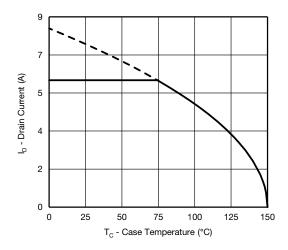


Single Pulse Power (Junction-to-Ambient)

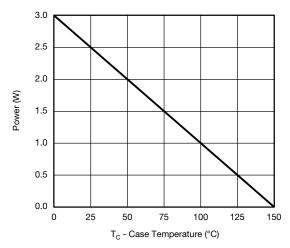


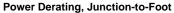
Safe Operating Area, Junction-to-Ambient

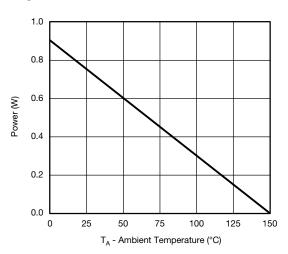




#### **Current Derating\***



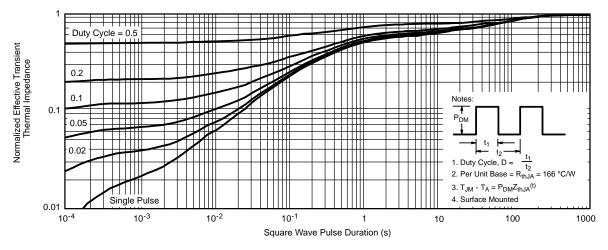




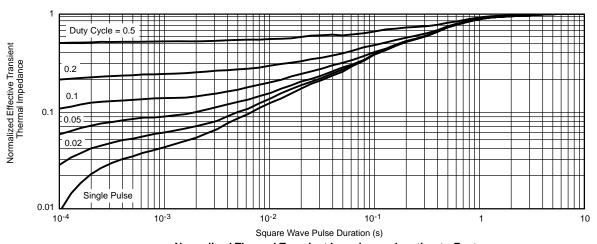
Power Derating, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





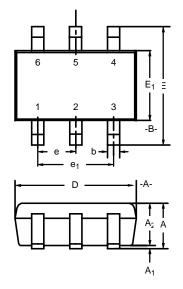
Normalized Thermal Transient Impedance, Junction-to-Ambient

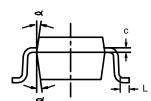


Normalized Thermal Transient Impedance, Junction-to-Foot



SC-70: 6-LEADS





	MIL	LIMET	ERS	INCHES			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	0.90	_	1.10	0.035	_	0.043	
<b>A</b> <sub>1</sub>	_	_	0.10	-	_	0.004	
A <sub>2</sub>	0.80	_	1.00	0.031	_	0.039	
b	0.15	-	0.30	0.006	-	0.012	
С	0.10	-	0.25	0.004	-	0.010	
D	1.80	2.00	2.20	0.071	0.079	0.087	
Ε	1.80	2.10	2.40	0.071	0.083	0.094	
E <sub>1</sub>	1.15	1.25	1.35	0.045	0.049	0.053	
е	0.65BSC			0.026BSC			
e <sub>1</sub>	1.20	1.30	1.40	0.047	0.051	0.055	
L	0.10	0.20	0.30	0.004	0.008	0.012	
۲		7°Nom	•		7°Nom		
ECN: S-03946—Rev. B. 09-Jul-01							

ECN: S-03940 DWG: 5550



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